Notice of References Cited Application/Control No. 10/565,394 Examiner Hau V. Phan Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-7,240,769	07-2007	Nezan et al.	181/250
*	В	US-6,863,154	03-2005	Uegane et al.	181/207
*	С	US-6,758,300	07-2004	Kromis et al.	180/309
*	D	US-6,536,548	03-2003	Steenackers et al.	180/89.2
*	Е	US-6,415,603	07-2002	Nowka et al.	60/322
*	F	US-6,260,652	07-2001	Steenackers et al.	180/296
*	G	US-6,173,800	01-2001	Steenackers et al.	180/89.2
*	н	US-6,058,702	05-2000	Jorg Alexnat et al.	60/322
*	ı	US-5,127,489	07-1992	Takato et al.	180/309
*	j	US-4,860,644	08-1989	Kohl et al.	454/65
*	К	US-4,676,332	06-1987	Saito, Akito	180/89.2
*	L	US-3,963,087	06-1976	Grosseau, Albert	180/309
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
-	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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